IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Stephane QUERTELET et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed May 27, 2005

Examiner

METHOD FOR MAKING A HOLD-DOWN BRACKET, CORRESPONDING CUT OUT BLANK AND BRACKET

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

May 27, 2005

Sir:

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Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

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	ket No. 0598-1004
III. CONCISE EXPLANATION OF THE RELEVANCE (check at least one box)	6 Rec'd PCT/PTO 27 MAY 20
a. DOCUMENTS IN THE ENGLISH LANG	BUAGE
The attached non U.S. patapplication publications, is other information in the require a statement of relev	foreign publications, or English language do not
b. DOCUMENTS NOT IN THE ENGLISH	LANGUAGE
A concise explanation of patents, publications, or that is not in the English l	the relevance of all other information listed anguage is as follows:
c. M FOREIGN SEARCH REPORT OR ACTI	ON
An English language version action that indicates the dominate by the foreign office satisfying the requiremember explanation. See MPEP 609(A)	legree of relevance found is attached, thereby sent for a concise
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The following additional inf the Examiner's consideration	
FEES	
This Information Disclosure State concurrently with the filing of a natherefore, no fee is required.	ement is being filed new patent application;
If The Examiner has any questions conis requested to contact the undersigned.	cerning this IDS, he/she
Respectfully submi	tted,
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Sheet	1	of	1

Attorney Docket No.: 0598-1004

May 27, 2005

Application No.:

NEW NATIONAL PHASE

INFORMATION	DISCLOSURE	CITATION
IN AN	APPLICATION	l

(Use several sheets if necessary)

Applicant:

Stephane QUERTELET et al.

Filing Date:

Group Art Unit:

U.S. PATENT DOCUMENTS

Old I / II DOOO III DIII O						
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing date (if appropriate)
	4,665,672	5/19/1987	LITTLETON ET AL		ľ	
	5,249,404	10/5/1993	LEEK ET AL.			
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FOREIGN PATENT DOCUMENTS

Examiner	Document Number	Date	Country	Class	Subclass	Translation	
Initial						Yes	No
	FR 2 740 805	5/9/1997	FRANCE				Х
	FR 2 773 568	7/16/1999	FRANCE				Х

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER:	DATE CONSIDERED	

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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^{*} English language abstract provided for the Examiner's convenience